# A/D Converter with Shutdown 

## feATURES

- Single Supply 5 V or $\pm 5 \mathrm{~V}$ Operation
- Sample Rate: 600ksps
- 70dB S/(N + D) and 74dB THD at Nyquist
- Power Dissipation: 60mW Typ
- Power Shutdown with Instant Wake-Up
- Internal Reference Can Be Overdriven Externally
- Internal Synchronized Clock; No Clock Required
- High Impedance Analog Input
- Input Range: 0 V to 5 V or $\pm 2.5 \mathrm{~V}$
- New Flexible, Friendly Paralle Interface Eases Connections to DSPs and FIFOs
- 24-Pin SO Wide Package


## APPLICATIONS

- High Speed Data Acquisition
- Digital Signal Processing
- Multiplexed Data Acquisition Systems
- Audio and Telecom Processing
- Spectrum Analysis


## DESCRIPTIOn

The $\operatorname{LTC}{ }^{\circledR} 1279$ is a $1.4 \mu \mathrm{~s}, 600 \mathrm{ksps}$, sampling 12 -bit A/D converter which draws only 60 mW from a single 5 V or $\pm 5 \mathrm{~V}$ supplies. This easy-to-use device comes complete with a 160 ns sample-and-hold, a precision reference and an internally trimmed clock. Unipolar and bipolar conversion modes add to the flexibility of the ADC. The low power dissipation is reduced even more, drawing only 8.5 mW in power shutdown mode. Instant wake-up from power shutdown allows the converter to be powered down even during brief inactive periods.

The LTC1279 converts 0 V to 5 V unipolar inputs from a single 5 V supply and $\pm 2.5 \mathrm{~V}$ bipolar inputs from $\pm 5 \mathrm{~V}$ supplies. Maximum DC specs include $\pm 1$ LSB INL and $\pm 1 \mathrm{LSB}$ DNL. Outstanding guaranteed AC performance includes $70 \mathrm{~dB} \mathrm{~S} /(\mathrm{N}+\mathrm{D})$ and 78 dB THD at the input frequency of 100 kHz over temperature.
The internal clock is trimmed for $1.4 \mu$ s conversion time. The clock automatically synchronizes to each sample command, eliminating problems with asynchronous clock noise found in competitive devices. A separate conversion start input and a data-ready signal ( $\overline{\mathrm{BUSY}}$ ) ease connections to FIFOs, DSPs and microprocessors.

## TYPICAL APPLICATION

Single 5V Supply, 600kHz, 12-Bit Sampling A/D Converter


Effective Bits and Signal-to-(Noise + Distortion) vs Input Frequency


## ABSOLUTE MAXImUM RATINGS

PACKAGE/ORDER INFORMATION
$A V_{D D}=D V_{D D}=V_{D D}$ (Notes 1, 2)
Supply Voltage (VDD)............................................... 7V
Negative Supply Voltage (VSS) Bipolar Operation Only $\qquad$ -6 V to GND
Total Supply Voltage ( $\mathrm{V}_{\mathrm{DD}}$ to $\mathrm{V}_{S S}$ ) Bipolar Operation Only 12V
Analog Input Voltage (Note 3)
Unipolar Operation $\qquad$ -0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$
Bipolar Operation............... $\mathrm{V}_{S S}-0.3 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$
Digital Input Voltage (Note 4)
Unipolar Operation $\qquad$ -0.3 V to 12 V
Bipolar Operation $V_{S S}-0.3 \mathrm{~V}$ to 12 V
Digital Output Voltage Unipolar Operation -0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$
Bipolar Operation -0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$
Power Dissipation $\qquad$ 500 mW
Operating Temperature Range
LTC1279C $\qquad$ $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
LTC1279 $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$
Storage Temperature Range ................ $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ Lead Temperature (Soldering, 10 sec ) $\qquad$ $300^{\circ} \mathrm{C}$

*Consult factory for plastic DIP package. Consult factory for Military grade parts.

COMVERTER CHARFCTERISTICS With Internal Reference (Notes 5, 6)

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNITS |
| :--- | :--- | :--- | :--- | ---: | ---: |
| Resolution (No Missing Codes) |  | $\bullet$ | 12 |  | Bits |
| Integral Linearity Error | (Note 7) | $\bullet$ |  | $\pm 1$ | LSB |
| Differential Linearity Error |  | $\bullet$ |  | $\pm 1$ | LSB |
| Bipolar Offset Error | (Note 8) | $\bullet$ | $\pm 4$ | LSB |  |
|  |  |  | $\pm 6$ | LSB |  |
| Unipolar Offset Error |  | $\bullet$ |  | $\pm 6$ | LSB |
| Gain Error |  | $\bullet$ | $\pm 8$ | LSB |  |
| Gain Error Tempco |  |  | $\pm 10$ | $\pm 45$ | ppm $/{ }^{\circ} \mathrm{C}$ |

## AnALOG IMPUT (Note 5)

| SYMBOL | PARAMETER | CONDITIONS | MIN | TYP | MAX |
| :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\text {IN }}$ | Analog Input Range (Note 9) | $4.95 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD}} \leq 5.25 \mathrm{~V}$ (Unipolar) | $\bullet$ | 0 to 5 |  |
|  |  | $4.75 \mathrm{~V} \leq \mathrm{V}_{\mathrm{DD}} \leq 5.25 \mathrm{~V},-5.25 \mathrm{~V} \leq \mathrm{V}_{\text {SS }} \leq-2.45 \mathrm{~V}$ (Bipolar) | $\bullet$ | V |  |
| $\mathrm{IN}_{\mathrm{IN}}$ | Analog Input Leakage Current | $\overline{\mathrm{CS}}=$ High | $\bullet$ | V |  |
| $\mathrm{C}_{\text {IN }}$ | Analog Input Capacitance | Between Conversions (Sample Mode) | $\pm 1$ | $\mu \mathrm{~A}$ |  |
|  |  | During Conversions (Hold Mode) | 25 | pF |  |

## DYMAMIC ACCURACY (Notes 5, 10)

| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| S/(N+D) | Signal-to-Noise Plus Distortion Ratio | 100kHz Input Signal 300kHz Input Signal | $\bullet$ | 70 | $\begin{aligned} & 72 \\ & 70 \end{aligned}$ |  | $\begin{aligned} & \mathrm{dB} \\ & \mathrm{~dB} \end{aligned}$ |
| THD | Total Harmonic Distortion First 5 Harmonics | 100kHz Input Signal 300kHz Input Signal | $\bullet$ |  | $\begin{aligned} & -82 \\ & -74 \end{aligned}$ | -78 | $\begin{aligned} & \mathrm{dB} \\ & \mathrm{~dB} \end{aligned}$ |
|  | Peak Harmonic or Spurious Noise | 100kHz Input Signal 300kHz Input Signal | $\bullet$ |  | $\begin{aligned} & -82 \\ & -80 \end{aligned}$ | -78 | $\begin{aligned} & \mathrm{dB} \\ & \mathrm{~dB} \end{aligned}$ |
| IMD | Intermodulation Distortion | $\begin{aligned} & \mathrm{f}_{\mathrm{IN} 1}=94.189 \mathrm{kHz}, \mathrm{f}_{\mathrm{IN2} 2}=97.705 \mathrm{kHz} \\ & \text { 2nd Order Terms } \\ & \text { 3rd Order Terms } \end{aligned}$ |  |  | $\begin{aligned} & -81 \\ & -78 \end{aligned}$ |  | dB dB |
|  |  | $\begin{aligned} & \mathrm{f}_{\mathrm{IN} 1}=299.26 \mathrm{kHz}, \mathrm{f}_{\mathrm{IN2} 2}=305.12 \mathrm{kHz} \\ & \text { 2nd Order Terms } \\ & \text { 3rd Order Terms } \end{aligned}$ |  |  | $\begin{aligned} & -77 \\ & -74 \end{aligned}$ |  | dB dB |
|  | Full Power Bandwidth |  |  |  | 5 |  | MHz |
|  | Full Linear Bandwidth (S/(N + D ) $\geq 68 \mathrm{~dB}$ ) |  |  |  | 500 |  | kHz |

## InTerninl $\boldsymbol{\beta \in f \in R \in \cap C \in ~ C H A R A C T \in R I S T I C S ~ ( N o t e ~ 5 ) ~}$

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNITS |
| :--- | :--- | :--- | :--- | :---: | :---: |
| $V_{\text {REF }}$ Output Voltage | $\mathrm{I}_{\text {OUT }}=0$ | 2.400 | 2.420 | 2.440 | V |
| $V_{\text {REF }}$ Output Tempco | $\mathrm{I}_{\text {OUT }}=0$ | $\bullet$ | $\pm 10$ | $\pm 45$ | $\mathrm{ppm} /{ }^{\circ} \mathrm{C}$ |
| $V_{\text {REF }}$ Line Regulation | $4.95 \mathrm{~V} \leq \mathrm{V}_{\text {DD }} \leq 5.25 \mathrm{~V}$ |  | 0.01 | $\mathrm{LSB} / \mathrm{V}$ |  |
|  | $-5.25 \mathrm{~V} \leq \mathrm{V}_{\text {SS }} \leq-4.95 \mathrm{~V}$ |  | 0.01 | $\mathrm{LSB} / \mathrm{V}$ |  |
| V $_{\text {REF }}$ Load Regulation | $-5 \mathrm{~mA} \leq \mathrm{I}_{\text {OUT }} \leq 800 \mu \mathrm{~A}$ |  | 2 | $\mathrm{LSB} / \mathrm{mA}$ |  |

## DIGITAL InPUTS ARD DIGITAL OUTPUTS (Note 5)

| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {IH }}$ | High Level Input Voltage | $V_{D D}=5.25 \mathrm{~V}$ | $\bullet$ | 2.4 |  |  | V |
| VIL | Low Level Input Voltage | $V_{D D}=4.95 \mathrm{~V}$ | $\bullet$ |  |  | 0.8 | V |
| IN | Digital Input Current | $\mathrm{V}_{\text {IN }}=0 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{DD}}$ | $\bullet$ |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {IN }}$ | Digital Input Capacitance |  |  |  | 5 |  | pF |
| $\mathrm{V}_{\mathrm{OH}}$ | High Level Output Voltage | $\begin{aligned} \mathrm{V}_{\mathrm{DD}} & =4.95 \mathrm{~V} \\ I_{0} & =-10 \mu \mathrm{~A} \\ \mathrm{I}_{0} & =-200 \mu \mathrm{~A} \end{aligned}$ | $\bullet$ | 4.0 | 4.9 |  | V |
| $\mathrm{V}_{0 \mathrm{~L}}$ | Low Level Output Voltage | $\begin{aligned} \mathrm{V}_{\mathrm{DD}} & =4.95 \mathrm{~V} \\ \mathrm{I}_{0} & =160 \mu \mathrm{~A} \\ I_{0} & =1.6 \mathrm{~mA} \end{aligned}$ | $\bullet$ |  | $\begin{aligned} & 0.05 \\ & 0.10 \end{aligned}$ | 0.4 | V |
| $\mathrm{I}_{02}$ | High-Z Output Leakage D11 to D0 | $\mathrm{V}_{\text {OUT }}=0 \mathrm{~V}$ to $\mathrm{V}_{\text {DD }}, \overline{\mathrm{CS}}$ High | $\bullet$ |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{02}$ | High-Z Output Capacitance D11 to D0 | $\overline{\overline{C S}}$ High (Note 9) | $\bullet$ |  |  | 15 | pF |
| ISOURCE | Output Source Current | $\mathrm{V}_{\text {OUT }}=0 \mathrm{~V}$ |  |  | -10 |  | mA |
| ISINK | Output Sink Current | $\mathrm{V}_{\text {OUT }}=\mathrm{V}_{\text {DD }}$ |  |  | 10 |  | mA |

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## LTC1279

POWER REQUIREMENTS (Note 5)

| SYMBOL | PARAMETER | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{D D}$ | Positive Supply Voltage (Notes 11, 12) | Unipolar Bipolar |  | $\begin{aligned} & 4.95 \\ & 4.75 \end{aligned}$ |  | $\begin{aligned} & 5.25 \\ & 5.25 \end{aligned}$ | V |
| $\mathrm{V}_{\text {SS }}$ | Negative Supply Voltage (Note 11, 12) | Bipolar Only |  | -2.45 |  | -5.25 | V |
| $l_{\text {D }}$ | Positive Supply Current | $\begin{aligned} & \mathrm{f}_{\mathrm{SAMPLE}}=600 \mathrm{ksps} \\ & \mathrm{SHDN}=0 \mathrm{~V} \end{aligned}$ | $\bullet$ |  | $\begin{aligned} & 12 \\ & 1.7 \end{aligned}$ | $\begin{array}{r} 24 \\ 3 \end{array}$ | mA |
| ISS | Negative Supply Current | $\mathrm{f}_{\text {SAMPLE }}=600 \mathrm{ksps}, \mathrm{V}_{\text {SS }}=-5 \mathrm{~V}$ | $\bullet$ |  | 0.12 | 0.30 | mA |
| $\mathrm{P}_{\mathrm{D}}$ | Power Dissipation | $\begin{aligned} & \mathrm{f}_{\mathrm{SAMPLE}}=600 \mathrm{ksps} \\ & \mathrm{SHDN}=0 \mathrm{~V} \end{aligned}$ | $\bullet$ |  | $\begin{aligned} & 60 \\ & 8.5 \end{aligned}$ | $\begin{gathered} 120 \\ 15 \end{gathered}$ | $\begin{aligned} & \mathrm{mW} \\ & \mathrm{~mW} \end{aligned}$ |

## TIMING CHARACTERISTICS (Note 5)

| SYMBOL | PARAMETER | CONDITIONS |  | MII | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {SAMPLE(MAX) }}$ | Maximum Sampling Frequency |  | $\bullet$ | 600 |  |  | kHz |
| $\mathrm{t}_{\text {SAMPLE(MIN }}$ | Minimum Throughput Time (Acquisition Time Plus Conversion Time) |  | $\bullet$ |  |  | 1.66 | $\mu \mathrm{S}$ |
| $\mathrm{t}_{\text {conv }}$ | Conversion Time |  | $\bullet$ |  | 1.4 | 1.6 | $\mu \mathrm{S}$ |
| $\mathrm{t}_{\mathrm{ACQ}}$ | Acquisition Time |  |  |  | 160 |  | ns |
| $\mathrm{t}_{1}$ | $\overline{\mathrm{CS}} \downarrow$ to $\overline{\mathrm{RD}} \downarrow$ Setup Time | (Notes 9, 11) | $\bullet$ | 0 |  |  | ns |
| $\mathrm{t}_{2}$ | $\overline{\text { CS }} \downarrow$ to $\overline{\text { CONVST }} \downarrow$ Setup Time | (Notes 9, 11) | $\bullet$ | 20 |  |  | ns |
| $t_{3}$ |  | (Note 11) |  |  | 350 |  | ns |
| $\mathrm{t}_{4}$ | $\overline{\text { CONVST Low Time }}$ | (Notes 11, 13) | $\bullet$ | 40 |  |  | ns |
| $\mathrm{t}_{5}$ | $\overline{\text { CONVST }} \downarrow$ to $\overline{B U S Y} \downarrow$ Delay | $\begin{aligned} & \mathrm{C}_{\mathrm{L}}=100 \mathrm{pF} \\ & \text { Commercial } \\ & \text { Industrial } \end{aligned}$ | $\bullet$ |  | 50 | $\begin{aligned} & 110 \\ & 130 \\ & 140 \end{aligned}$ | ns ns ns |
| $t_{6}$ | Data Ready Before $\overline{\mathrm{BUSY}} \uparrow$ | $\mathrm{C}_{\mathrm{L}}=20 \mathrm{pF}$ | $\bullet$ | 20 | 40 |  | ns |
| $\mathrm{t}_{7}$ | Wait Time $\overline{\mathrm{RD}} \downarrow$ After $\overline{\mathrm{BUSY}} \uparrow$ | Mode 2, (See Figure 14) (Note 9) | $\bullet$ | -2 |  |  | ns |
| $\mathrm{t}_{8}$ | Data Access Time After $\overline{\mathrm{RD}} \downarrow$ | $\mathrm{C}_{\mathrm{L}}=20 \mathrm{pF} \text { (Note } 9 \text { ) }$ <br> Commercial Industrial | $\bullet$ |  | 35 | $\begin{gathered} \hline 90 \\ 110 \\ 120 \\ \hline \end{gathered}$ | ns ns ns |
|  |  | $C_{L}=100 \mathrm{pF}$ <br> Commercial Industrial | $\bullet$ |  | 50 | $\begin{aligned} & \hline 125 \\ & 150 \\ & 170 \\ & \hline \end{aligned}$ | ns ns ns |
| $\mathrm{t}_{9}$ | Bus Relinquish Time | ( 3 k and 10pF Connected as Shown in Test Circuits) <br> Commercial Industrial | $\bullet$ | 10 10 10 | 30 | $\begin{aligned} & 75 \\ & 85 \\ & 90 \end{aligned}$ | ns ns ns |
| $\mathrm{t}_{10}$ | $\overline{\mathrm{RD}}$ Low Time | (Note 9) | $\bullet$ | t |  |  | ns |
| $\mathrm{t}_{11}$ | $\overline{\text { CONVST }}$ High Time | (Notes 9, 13) | $\bullet$ | 40 |  |  | ns |
| $\mathrm{t}_{12}$ | Aperture Delay of Sample-and-Hold | Jitter < 50ps |  |  | 12 |  | ns |

## TIMInG CHARACTERISTICS (Note 5)

The indicates specifications which apply over the full operating temperature range; all other limits and typicals $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
Note 1: Absolute maximum ratings are those values beyond which the life of a device may be impaired.
Note 2: All voltage values are with respect to ground with DGND and AGND wired together (unless otherwise noted).
Note 3: When the analog input voltage is taken below $\mathrm{V}_{S S}$ (ground for unipolar mode) or above $V_{D D}$, it will be clamped by internal diodes. This product can handle input currents greater than 80 mA below $\mathrm{V}_{\text {SS }}$ (ground for unipolar mode) or above $V_{D D}$ without latch-up.
Note 4: When these pin voltages are taken below $\mathrm{V}_{S S}$ (ground for unipolar mode), they will be clamped by internal diodes. This product can handle input currents greater than 60 mA below $\mathrm{V}_{\text {SS }}$ (ground for unipolar mode) without latch-up. These pins are not clamped to $V_{D D}$.
Note 5: $\mathrm{AV}_{\mathrm{DD}}=\mathrm{DV} \mathrm{V}_{\mathrm{DD}}=\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}$, ( $\mathrm{V}_{\mathrm{SS}}=-5 \mathrm{~V}$ for bipolar mode $)$, $\mathrm{f}_{\mathrm{SAMPLE}}=$ $600 \mathrm{kHz}, \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=5 \mathrm{~ns}$ unless otherwise specified.
Note 6: Linearity, offset and full scale specifications apply for unipolar and bipolar modes.

Note 7: Integral nonlinearity is defined as the deviation of a code from a straight line passing through the actual endpoints of the transfer curve. The deviation is measured from the center of the quantization band.
Note 8: Bipolar offset is the offset voltage measured from $-1 / 2$ LSB when the output code flickers between 000000000000 and 111111111111.

Note 9: Guaranteed by design, not subject to test.
Note 10: The AC test is for bipolar mode. The signal-to-noise plus distortion ratio is about 1 dB lower for unipolar mode, so the typical $\mathrm{S} /(\mathrm{N}+\mathrm{D})$ at 100 kHz in unipolar mode is 71 dB .
Note 11: Recommended operating conditions.
Note 12: $A_{I N}$ must not exceed $V_{D D}$ or fall below $V_{S S}$ by more than 50 mV for specified accuracy. Therefore the minimum supply voltage for the unipolar mode is 4.95 V . The minimum for the bipolar mode is $4.75 \mathrm{~V},-2.45 \mathrm{~V}$.
Note 13: The falling $\overline{\text { CONVST }}$ edge starts a conversion. If $\overline{\text { CONVST }}$ returns high at a bit decision point during the conversion it can create small errors. For best performance ensure that CONVST returns high either within 120ns after conversion start (i.e., before the first bit decision) or after BUSY rises (i.e., after the last bit test). See mode 1a and 1b (Figures 12 and 13) timing diagrams.

## TYPICAL PGRFORMANCE CHARACTERISTICS



## TYPICAL PERFORMANCE CHARACTERISTICS



Peak Harmonic or Spurious Noise vs Input Frequency


1279 G07

Signal-to-Noise Ratio (Without Harmonics) vs Input Frequency


1279 G05

Intermodulation Distortion Plot


1279 G08


Acquisition Time vs Source Impedance



1279 G10

Power Supply Feedthrough vs Ripple Frequency



Reference Voltage vs Load Current

## PIn fUnCTIOnS

$\mathrm{A}_{\text {IN }}$ (Pin 1): Analog Input. 0 V to 5 V (Unipolar), $\pm 2.5 \mathrm{~V}$ (Bipolar).
VREF (Pin 2): 2.42V Reference Output. Bypass to AGND ( $10 \mu \mathrm{~F}$ tantalum in parallel with $0.1 \mu \mathrm{~F}$ ceramic).
AGND (Pin 3): Analog Ground.
D11 to D4 (Pins 11 to 4): Three-State Data Outputs. D11 is the Most Significant Bit.
DGND (Pin 12): Digital Ground.
D3 to D0 (Pins 13 to 16): Three-State Data Outputs.
DV ${ }_{D D}$ (Pin17): Digital Power Supply, 5 V . Tie to $A V_{D D}$ pin.
SHDN (Pin 18): Power Shutdown. The LTC1279 powers down when SHDN is low.
CONVST (Pin 19): Conversion Start Input. It is active low. The falling edge of the CONVST signal initiates a
conversion. The LTC1279 responds to CONVST signal only if the signal applied to $\overline{C S}$ is a logic low.
$\overline{\mathbf{R D}}$ (Pin 20): READ Input. A logic low signal applied to this pin enables the output data drivers when the signal applied to the CS pin is a logic low.
$\overline{\mathbf{C S}}$ (Pin21): The CHIP SELECT input must bea logic low for the ADC to recognize the signals applied to the CONVST and $\overline{\mathrm{RD}}$ inputs.
BUSY (Pin 22): The BUSY output shows the converter status. It is a logic low during a conversion.
$\mathbf{V}_{\text {ss }}$ (Pin 23): Negative Supply. -5 V will select bipolar operation. Bypass to AGND with $0.1 \mu \mathrm{~F}$ ceramic. Tie to analog ground to select unipolar operation.
AV ${ }_{D D}$ (Pin 24): Positive Supply, 5V. Bypass to AGND ( $10 \mu \mathrm{~F}$ tantalum in parallel with $0.1 \mu \mathrm{~F}$ ceramic).

## fUnCTIONAL BLOCK DIAGRAM



Load Circuits for Access Timing

A) $\mathrm{HIGH}-\mathrm{Z} \mathrm{TO} \mathrm{V}_{\mathrm{OH}}\left(\mathrm{t}_{8}\right)$ AND $V_{O L} T O V_{O H}\left(\mathrm{t}_{6}\right)$

A) $\mathrm{V}_{\mathrm{OH}}$ TO HIGH-Z

B) $\mathrm{V}_{\mathrm{OL}}$ TO HIGH-Z

## timing DIAGRAMS



CS to CONVST Setup Timing

$\overline{\text { SHDN }}$ to $\overline{\text { CONVST }}$ Wake-Up Timing


## APPLICATIONS INFORMATION

## CONVERSION DETAILS

The LTC1279 uses a successive approximation algorithm and an internal sample-and-hold circuit to convert an analog signal to a 12-bit parallel output. The ADC is complete with a precision reference and an internal clock. The control logic provides easy interface to microprocessors and DSPs. (Please refer to the Digital Interface section for the data format.)
Conversion start is controlled by the $\overline{\mathrm{CS}}$ and $\overline{\text { CONVST }}$ inputs. At the start of conversion the successive approximation register (SAR) is reset. Once a conversion cycle has begun it cannot be restarted.

During conversion, the internal 12-bit capacitive DAC output is sequenced by the SAR from the most significant bit (MSB) to the least significant bit (LSB). Referring to Figure 1, the $A_{I N}$ input connects to the sample-and-hold capacitor during the acquire phase, and the comparator offset is nulled by the feedback switch. In this acquire phase, a minimum delay of 160 ns will provide enough

time for the sample-and-hold capacitor to acquire the analog signal. During the convert phase, the comparator feedback switch opens, putting the comparator into the compare mode. The input switch switches CsAMPLE to ground, injecting the analog input charge onto the summing junction. This input charge is successively com-

## APPLICATIONS INFORMATION

pared with the binary-weighted charges supplied by the capacitive DAC. Bit decisions are made by the high speed comparator. At the end of a conversion, the DAC output balances the $\mathrm{A}_{\text {IN }}$ input charge. The SAR contents (a 12-bit data word) which represent the $A_{\text {IN }}$ are loaded into the 12-bit output latches.

## DYNAMIC PERFORMANCE

The LTC1279 has excellent high speed sampling capability. FFT (Fast Fourier Transform) test techniques are used to test the ADC's frequency response, distortion and noise at the rated throughput. By applying a low distortion sine wave and analyzing the digital output using an FFT algorithm, the ADC's spectral content can be examined for frequencies outside the fundamental. Figures 2a and 2 b show typical LTC1279 FFT plots.


Figure 2a. LTC1279 Nonaveraged, 4096 Point FFT Plot with 100 kHz Input Frequency


1279 F02
Figure 2b. LTC1279 Nonaveraged, 4096 Point FFT Plot with 300 kHz Input Frequency

## Signal-to-Noise Ratio

The Signal-to-Noise plus Distortion Ratio [S/(N + D)] is the ratio between the RMS amplitude of the fundamental input frequency to the RMS amplitude of all other frequency components at the A/D output. The output is band limited to frequencies above DC and below half the sampling frequency. Figure 2a shows a typical spectral content with a 600 kHz sampling rate and a 100 kHz input. The dynamic performance is excellent for input frequencies up to the Nyquist limit of 300 kHz as shown in Figure 2b.

## Effective Number of Bits

The Effective Number of Bits (ENOBs) is a measurement of the resolution of an ADC and is directly related to the $\mathrm{S} /(\mathrm{N}+\mathrm{D})$ by the equation:

$$
N=[S /(N+D)-1.76] / 6.02
$$

where $N$ is the Effective Number of Bits of resolution and $S /(N+D)$ is expressed in $d B$. At the maximum sampling rate of 600kHz the LTC1279 maintains very good ENOBs up to the Nyquist input frequency of 300 kHz . Refer to Figure 3.


Figure 3. Effective Bits and Signal/(Noise + Distortion) vs Input Frequency

## Total Harmonic Distortion

Total Harmonic Distortion (THD) is the ratio of the RMS sum of all harmonics of the input signal to the fundamental itself. The out-of-band harmonics alias into the frequency band between DC and half the sampling frequency. THD is expressed as:

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$$
T H D=20 \log \frac{\sqrt{V_{2}{ }^{2}+V_{3}{ }^{2}+V_{4}{ }^{2} \ldots+V_{N}{ }^{2}}}{V_{1}}
$$

where $\mathrm{V}_{1}$ is the RMS amplitude of the fundamental frequency and $\mathrm{V}_{2}$ through $\mathrm{V}_{\mathrm{N}}$ are the amplitudes of the second through Nth harmonics. THD versus input frequency is shown in Figure 4. The LTC1279 has good distortion performance up to the Nyquist frequency and beyond.


Figure 4. Distortion vs Input Frequency

## Intermodulation Distortion

If the ADC input signal consists of more than one spectral component, the ADC transfer function nonlinearity can produce intermodulation distortion (IMD) in addition to THD. IMD is the change in one sinusoidal input caused by the presence of another sinusoidal input at a different frequency.

If two pure sine waves of frequencies fa and fb are applied to the ADC input, nonlinearities in the ADC transfer function can create distortion products at sum and difference frequencies of $\mathrm{mfa} \pm \mathrm{nfb}$, where m and $\mathrm{n}=0,1,2,3$, etc. For example, the 2nd order IMD terms include (fa +fb ) and ( $\mathrm{fa}-\mathrm{fb}$ ) while the 3rd order IMD terms include ( $2 \mathrm{fa}+\mathrm{fb}$ ), ( $2 \mathrm{fa}-\mathrm{fb}$ ), (fa +2 fb ), and (fa $-2 \mathrm{fb})$. If the two input sine waves are equal in magnitude, the value (in decibels) of the 2nd order IMD products can be expressed by the following formula:

$$
\text { IMD }(\mathrm{fa} \pm \mathrm{fb})=20 \log \frac{\text { Amplitude at }(\mathrm{fa} \pm \mathrm{fb})}{\text { Amplitude at } \mathrm{fa}}
$$

Figure 5 shows the IMD performance at a 100 kHz input.


1279G08
Figure 5. Intermodulation Distortion Plot

## Peak Harmonic or Spurious Noise

The peak harmonic or spurious noise is the largest spectral component excluding the input signal and DC. This value is expressed in decibels relative to the RMS value of a full scale input signal.

## Full Power and Full Linear Bandwidth

The full power bandwidth is that input frequency at which the amplitude of the reconstructed fundamental is reduced by 3 dB for a full scale input signal.
The full linear bandwidth is the input frequency at which the $\mathrm{S} /(\mathrm{N}+\mathrm{D})$ has dropped to 68dB (11 effective bits). The LTC1279 has been designed to optimize input bandwidth, allowing ADC to undersample input signals with frequencies above the converter's Nyquist Frequency. The noise floor stays very low at high frequencies; $\mathrm{S} /(\mathrm{N}+\mathrm{D})$ becomes dominated by distortion at frequencies far beyond Nyquist.

## Driving the Analog Input

The LTC1279's analog input is easy to drive. It draws only one small current spike while charging the sample-andhold capacitor at the end of conversion. During conversion the analog input draws no current. The only requirement is that the amplifier driving the analog input must settle after the small current spike before the next conversion starts. Any op amp that settles in 160ns to small current transients will allow maximum speed operation. If slower

## APPLICATIONS INFORMATION

op amps are used, more settling time can be provided by increasing the time between conversions. Suitable devices capable of driving the ADC's $A_{\text {IN }}$ input include the LT ${ }^{\circledR} 1360$, LT1220, LT1223 and LT1224 op amps.

## Internal Reference

The LTC1279 has an on-chip, temperature compensated, curvature corrected, bandgap reference that is factory trimmed to 2.42V. It is internally connected to the DAC and is available at pin 2 to provide up to $800 \mu \mathrm{~A}$ current to an external load.
For minimum code transition noise, the reference output should be decoupled with a capacitor to filter wideband noise from the reference ( $10 \mu \mathrm{~F}$ tantalum in parallel with a $0.1 \mu \mathrm{~F}$ ceramic).

The $V_{\text {REF }}$ pin can be driven with a DAC or other means to provide input span adjustment in bipolar mode. The $\mathrm{V}_{\text {REF }}$ pin must be driven to at least 2.45 V to prevent conflict with the internal reference. The reference should be driven to no more than 4.8 V to keep the input span within the $\pm 5 \mathrm{~V}$ supplies.

Figure 6 shows an LT1006 op amp driving the $\mathrm{V}_{\text {REF }}$ pin. (In the unipolar mode, the input span is already 0 V to 5 V with


Figure 6. Driving the $V_{\text {REF }}$ with the LT1006 Op Amp


Figure 7. Supplying a 2.5 V Reference Voltage to the LTC1279 with the LT1019A-2.5
the internal reference so driving the reference is not recommended, since the input span will exceed the supply and codes will be lost at the full scale.) Figure 7 shows a typical reference, the LT1019A-2.5 connected to the LTC1279. This will provide an improved drift (equal to the LT1019A-2.5's maximum of $5 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ ) and $\mathrm{a} \pm 2.582 \mathrm{~V}$ full scale.

## UNIPOLAR/BIPOLAR OPERATION AND ADJUSTMENT

Figure 8a shows the ideal input/output characteristics for the LTC1279. The code transitions occur midway between successive integer LSB values (i.e., 0.5LSB, 1.5LSB, $2.5 \mathrm{LSB}, \ldots \mathrm{FS}-1.5 \mathrm{LSB}$ ). The output code is naturally binary with $1 \mathrm{LSB}=\mathrm{FS} / 4096=5 \mathrm{~V} / 4096=1.22 \mathrm{mV}$. Figure 8 b shows the input/output transfer characteristics for the bipolar mode in two's complement format.


Figure 8a. LTC1279 Unipolar Transfer Characteristics


Figure 8b. LTC1279 Bipolar Transfer Characteristics

## APPLICATIONS INFORMATION

## Unipolar Offset and Full-Scale Error Adjustments

In applications where absolute accuracy is important, offset and full-scale errors can be adjusted to zero. Offset error must be adjusted before full-scale error. Figure 9a shows the extra components required for full-scale error adjustment. If both offset and full-scale adjustments are needed, the circuit in Figure 9b can be used. For zero offset error apply 0.61 mV (i.e., 0.5 LSB ) at the input and adjust the offset trim until the LTC1279 output code flickers between 000000000000 and 000000000001 . For zero full-scale error apply an analog input of 4.99817 V (i.e., FS - 1.5LSB or last code transition) at the input and adjust R5 until the LTC1279 output code flickers between 1111 11111110 and 111111111111.


Figure 9a. Full-Scale Adjust Circuit


Figure 9b. LTC1279 Unipolar Offset and Full-Scale Adjust Circuit


Figure 9c. LTC1279 Bipolar Offset and Full-Scale Adjust Circuit

## Bipolar Offset and Full-Scale Error Adjustments

Bipolar offset and full-scale errors are adjusted in a similar fashion to the unipolar case. Again, bipolar offset must be adjusted before full-scale error. Bipolar offset error adjustment is achieved by trimming the offset of the op amp driving the analog input of the LTC1279 while the input voltage is 0.5 LSB below ground. This is done by applying an input voltage of $-0.61 \mathrm{mV}(-0.5 \mathrm{LSB})$ to the input in Figure 9 c and adjusting the R8 until the ADC output code flickers between 000000000000 and 111111111111. For full scale adjustment, an input voltage of 2.49817 V (FS - 1.5LSBs) is applied to the input and R5 is adjusted until the output code flickers between 011111111110 and 011111111111.

## BOARD LAYOUT AND BYPASSING

Wire wrap boards are not recommended for high resolution or high speed $A / D$ converters. To obtain the best performance from the LTC1279, a printed circuit board is required. The printed circuit board's layout should ensure that digital and analog signal lines are separated as much as possible. In particular, care should be taken not to run any digital trace alongside an analog signal trace or underneath the ADC. The analog input should be screened by AGND.
High quality tantalum and ceramic bypass capacitors should be used at the $A V_{D D}$ and $V_{\text {REF }}$ pins as shown in Figure 10. For the bipolar mode, a $0.1 \mu$ F ceramic provides

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Figure 10. Power Supply Grounding Practice
adequate bypassing for the $\mathrm{V}_{\mathrm{SS}}$ pin. The capacitors must be located as close to the pins as possible. The traces connecting the pins and the bypass capacitors must be kept short and should be made as wide as possible.

Input signal traces to $A_{\text {IN }}$ (pin 1) and signal return traces from AGND (pin 3) should be kept as short as possible to minimize input noise coupling. In applications where this is not possible, a shielded cable between the signal source and ADC is recommended. Also, since any potential difference in grounds between the signal source and ADC appears as an error voltage in series with the input signal, attention should be paid to reducing the ground circuit impedances as much as possible.
A single point analog ground, separate from the logic system ground, should be established with an analog ground plane at pin 3 (AGND) or as close as possible to the ADC. Pin 12 (DGND) and all other analog grounds should be connected to this single analog ground point. No other digital grounds should be connected to this analog ground point. Low impedance analog and digital power supply common returns are essential to low noise operation of the ADC and the foil width for these tracks should be as wide as possible. In applications where the ADC data outputs and control signals are connected to a continuously active microprocessor bus, it is possible to get errors in conversion results. These errors are due to feedthrough from the microprocessor to the successive approximation comparator. The problem can be eliminated by forcing the microprocessor into a WAIT state during conversion or by using three-state buffers to isolate the ADC data bus.

## DIGITAL INTERFACE

The A/D converter is designed to interface with microprocessors as a memory mapped device. The $\overline{\mathrm{CS}}$ and $\overline{\mathrm{RD}}$ control inputs are commonto all peripheral memory interfacing. A separate CONVST is used to initiate a conversion.

## Internal Clock

The A/D converter has an internal clock that eliminates the need of synchronization between the external clock and the $\overline{\mathrm{CS}}$ and $\overline{\mathrm{RD}}$ signals found in other ADCs. The internal clock is factory trimmed to achieve a typical conversion time of $1.4 \mu \mathrm{~s}$. No external adjustments are required, and with the typical acquisition time of 160 ns , throughput performance of 600 ksps is assured.

## Power Shutdown

The LTC1279 provides a power shutdown feature that saves power when the ADC is in inactive periods. To power down the ADC, pin 18 (SHDN) needs to be driven low. When in power shutdown mode, the LTC1279 will not start a conversion even though the CONVST goes low. All the power is off except the Internal Reference which is still active and provides 2.42 V output voltage to the other circuitry. In this mode the ADC draws 8.5 mW instead of 60 mW (for minimum power, the logic inputs must be within 600 mV of the supply rails). The wake-up time from the power shutdown to active state is 350 ns .

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## APPLICATIONS InFORMATION

## Timing and Control

Conversion start and data read operations are controlled by three digital inputs: $\overline{\mathrm{CS}}, \overline{\mathrm{CONVST}}$ and $\overline{\mathrm{RD}}$. Figure 11 shows the logic structure associated with these inputs. A logic " 0 " for CONVST will start a conversion after the ADC has been selected (i.e., $\overline{\mathrm{CS}}$ is low). Once initiated, it cannot be restarted until the conversion is complete. Converter status is indicated by the BUSY output, and this is low while conversion is in progress.
Figures 12 through 16 show several different modes of operation. In modes 1a and 1b (Figures 12 and 13) CS and $\overline{\mathrm{RD}}$ are both tied low. The falling CONVST starts the conversion. The data outputs are always enabled and data can be latched with the BUSY rising edge. Mode 1a shows operation with a narrow logic low CONVST pulse. Mode 1b shows a narrow logic high CONVST pulse.
In mode 2 (Figure 14) $\overline{\mathrm{CS}}$ is tied low. The falling CONVST signal again starts the conversion. Data outputs are in three-state until read by MPU with the RD signal. Mode 2 can be used for operation with a shared MPU databus.

In Slow memory and ROM modes (Figures 15 and 16) $\overline{C S}$ is tied low and $\overline{C O N V S T}$ and $\overline{R D}$ are tied together. The MPU starts conversion and reads the output with the $\overline{\mathrm{RD}}$ signal. Conversions are started by the MPU or DSP (no external sample clock).

In Slow memory mode the processor applies a logic low to $\overline{\mathrm{RD}}$ (= $\overline{\mathrm{CONVST}})$, starting the conversion. $\overline{\mathrm{BUSY}}$ goes low, forcing the processor into a WAIT state. The previous conversion result appears on the data outputs. When the conversion is complete, the new conversion results appear on the data outputs; BUSY goes high, releasing the processor; the processor applies a logic high to $\overline{\mathrm{RD}}$ (= $\overline{\text { CONVST }}$ ) and reads the new conversion data.
In ROM mode, the processor applies a logic low to $\overline{\mathrm{RD}}$ (= CONVST), starting a conversion and reading the previous conversion result. After the conversion is complete, the processor can read the new result (which will initiate another conversion).


Figure 11. Internal Logic for Control Inputs $\overline{\mathrm{CS}}, \overline{\mathrm{RD}}, \overline{\mathrm{CONVST}}$ and $\overline{\text { SHDN }}$



## APPLICATIONS INFORMATION



Figure 13. Mode 1b. $\overline{\text { CONVST }}$ Starts a Conversion. Data Outputs Always Enabled. $(\overline{\mathrm{CONVST}}=\sqrt{\mathrm{Z}} \quad \mathrm{Z}$ )


Figure 14. Mode 2. CONVST Starts a Conversion. Data is Read by $\overline{\mathrm{RD}}$


Figure 15. Slow Memory Mode


Figure 16. ROM Mode Timing tation that the interconnection of its circuits as described herein will not infringe on existing patent rights.

## PACKAGE DESCRIPTION Dimensions in incheses millimeaters unless oltemisise noled.

## S Package 24-Lead Plastic SOL



NOTE:
SOL24 0392

1. PIN 1 IDENT, NOTCH ON TOP AND CAVITIES ON THE BOTTOM OF PACKAGES ARE THE MANUFACTURING OPTIONS. THE PART MAY BE SUPPLIED WITH OR WITHOUT ANY OF THE OPTIONS.
2. THESE DIMENSIONS DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS. MOLD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.006 INCH ( 0.15 mm ).

## RELATGD PARTS <br> (12 Bit)

| PART NUMBER | DESCRIPTION | COMMENTS |
| :--- | :--- | :--- |
| LTC1272 | 12 -Bit, 3 $\mu \mathrm{s}$, 250kHz Sampling A/D Converter | Single 5V, Sampling 7572 Upgrade |
| LTC1273/LTC1275/LTC1276 | 12 -Bit, 300ksps Sampling A/D Converters with Reference | Complete with Clock, Reference |
| LTC1274/LTC1277 | 12 -Bit, 10mW, 100ksps A/D Converters with 1 $\mu$ A Shutdown | Complete with Clock, Reference |
| LTC1278 | 12 -Bit, 500 ksps Sampling A/D Converter with Shutdown | 70dB SINAD at Nyquist, Low Power |
| LTC1282 | 3V, 140ksps 12-Bit Sampling A/D Converter with Reference | 3V or $\pm 3 V$ ADC with Reference, Clock |
| LTC1409 | 12-Bit, 800ksps Sampling A/D Converter with Shutdown | Fast, Complete Low Power ADC |
| LTC1410 | 12-Bit, 1.25Msps Sampling A/D Converter with Shutdown | Fast, Complete, Wideband ADC |

